



# **DIM500ACM65-TS000**

## **IGBT Chopper Module**

DS6182-2 July 2017 (LN34586)

# Replaces DS6182-1

**FEATURES** 

## 10µs Short Circuit Withstand

- High Thermal Cycling Capability
- Soft Punch Through Silicon
- Isolated AISiC Base with AIN Substrates
- Lead Free construction

#### **APPLICATIONS**

- High Reliability Inverters
- Motor Controllers
- Traction Drives
- Choppers

The Powerline range of high power modules includes half bridge, chopper, dual, single and bi-directional switch configurations covering voltages from 600V to 6500V and currents up to 2400A.

The DIM500ACM65-TS000 is a 6500V, soft punch through n-channel enhancement mode, insulated gate bipolar transistor (IGBT) chopper module. The IGBT has a wide reverse bias safe operating area (RBSOA) plus 10µs short circuit withstand. This device is optimised for traction drives and other applications requiring high thermal cycling capability.

The module incorporates an electrically isolated base plate and low inductance construction enabling circuit designers to optimise circuit layouts and utilise grounded heat sinks for safety.

#### **ORDERING INFORMATION**

Order As:

#### DIM500ACM65-TS000

Note: When ordering, please use the complete part number

#### **KEY PARAMETERS**

V <sub>CES</sub>		6500V
V <sub>CE(sat)</sub>	* (typ)	3.0V
l <sub>c</sub> ` ´	(max)	500A
I <sub>C(PK)</sub>	(max)	1000A

<sup>\*</sup> Measured at the auxiliary terminals

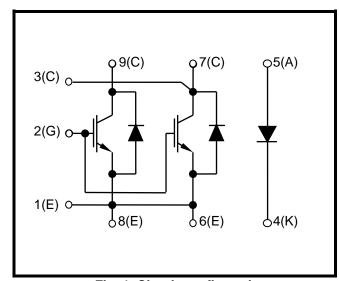


Fig. 1 Circuit configuration



Fig. 2 Package

## **ABSOLUTE MAXIMUM RATINGS**

Stresses above those listed under 'Absolute Maximum Ratings' may cause permanent damage to the device. In extreme conditions, as with all semiconductors, this may include potentially hazardous rupture of the package. Appropriate safety precautions should always be followed. Exposure to Absolute Maximum Ratings may affect device reliability.

T<sub>case</sub> = 25°C unless stated otherwise

Symbol	Parameter	Test Conditions	Max.	Units
	Collector-emitter voltage	V <sub>GE</sub> = 0V, T <sub>j</sub> = 125°C	6500	V
$V_{CES}$		$V_{GE} = 0V, T_j = 25^{\circ}C$	6500	V
		$V_{GE} = 0V, T_j = -40^{\circ}C$	6000	V
$V_{GES}$	Gate-emitter voltage		±20	V
I <sub>C</sub>	Continuous collector current	T <sub>case</sub> = 95°C	500	Α
I <sub>C(PK)</sub>	Peak collector current	1ms, T <sub>case</sub> = 115°C	1000	Α
P <sub>max</sub>	Max. transistor power dissipation	$T_{case} = 25^{\circ}C, T_{j} = 125^{\circ}C$	6.6	kW
l <sup>2</sup> t	Diode I <sup>2</sup> t value (IGBT arm)	V 0 4 40mg T 435°C	90	kA2s
ΙT	Diode I <sup>2</sup> t value (Diode arm)	$V_R = 0$ , $t_p = 10$ ms, $T_j = 125$ °C		kA <sup>2</sup> s
V <sub>isol</sub>	Isolation voltage – per module	Commoned terminals to base plate. AC RMS, 1 min, 50Hz	10.2	kV
$Q_{PD}$	Partial discharge – per module	IEC1287, V <sub>1</sub> = 6900V, V <sub>2</sub> = 5100V, 50Hz RMS	10	рC

## THERMAL AND MECHANICAL RATINGS

Internal insulation material:

Baseplate material:

Creepage distance:

Clearance:

CTI (Comparative Tracking Index):

AIN

AISiC

56mm

26mm

>600

Symbol	Parameter	Test Conditions	Min	Тур.	Max	Units
R <sub>th(j-c)</sub>	Thermal resistance – transistor	Continuous dissipation – junction to case			15	°C/kW
R <sub>th(j-c)</sub>	Thermal resistance – diode (IGBT arm)	Continuous dissipation – junction to case			30	°C/kW
R <sub>th(j-c)</sub>	Thermal resistance – diode (Diode arm)	Continuous dissipation – junction to case			30	°C/kW
R <sub>th(c-h)</sub>	Thermal resistance – case to heatsink	Mounting torque 5Nm (with mounting grease)			8	°C/kW
Tj	Junction temperature	Transistor			125	°C
		Diode			125	°C
T <sub>stg</sub>	Storage temperature range		-40		125	°C
		Mounting – M6			5	Nm
	Screw torque	Electrical connections – M4			2	Nm
		Electrical connections – M8			10	Nm

## **ELECTRICAL CHARACTERISTICS**

 $T_{case}$  = 25°C unless stated otherwise.

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
_	Collector cut-off current	$V_{GE} = 0V$ , $V_{CE} = V_{CES}$			1	mA
I <sub>CES</sub>		$V_{GE} = 0V$ , $V_{CE} = V_{CES}$ , $T_{case} = 125$ °C			60	mA
I <sub>GES</sub>	Gate leakage current	$V_{GE} = \pm 20V, V_{CE} = 0V$			1	μA
V <sub>GE(TH)</sub>	Gate threshold voltage	$I_C = 80$ mA, $V_{GE} = V_{CE}$	5.5	6.5	7.5	V
V	Collector-emitter saturation	V <sub>GE</sub> = 15V, I <sub>C</sub> = 500A		3.0		V
$V_{CE(sat)}$	voltage	V <sub>GE</sub> = 15V, I <sub>C</sub> = 500A, T <sub>j</sub> = 125°C		4.0		V
I <sub>F</sub>	Diode forward current	DC			500	Α
I <sub>FM</sub>	Diode maximum forward current	t <sub>p</sub> = 1ms			1000	Α
$V_{F}$	Diode forward voltage	I <sub>F</sub> = 500A		3.6		V
VF		$I_F = 500A, T_j = 125^{\circ}C$		4.3		V
$C_{ies}$	Input capacitance	$V_{CE} = 25V, V_{GE} = 0V, f = 1MHz$		8		nF
$Q_g$	Gate charge	±15V		7		μC
$C_{res}$	Reverse transfer capacitance	V <sub>CE</sub> = 25V, V <sub>GE</sub> = 0V, f = 1MHz		1.6		nF
	Module inductance	IGBT		20		nΗ
L <sub>M</sub>		Diode		25		nΗ
-	Internal resistance	IGBT		180		μΩ
$R_{INT}$		Diode		360		μΩ
SC <sub>Data</sub>	Short circuit current, I <sub>SC</sub>	$T_{j} = 125$ °C, $V_{CC} = 4400V$ $t_{p} \le 10 \mu s$ , $V_{GE} \le 15 V$ $V_{CE (max)} = V_{CES} - L^{*} x dI/dt$ IEC 60747-9		2500		А

## Note:

L is the circuit inductance + L<sub>M</sub>

## **ELECTRICAL CHARACTERISTICS**

T<sub>case</sub> = 25°C unless stated otherwise

Symbol	Parameter	Test Conditions	Min	Тур.	Max	Units
t <sub>d(off)</sub>	Turn-off delay time	$I_{C} = 500A$ $V_{GE} = \pm 15V$		3.6		μs
t <sub>f</sub>	Fall time			450		ns
E <sub>OFF</sub>	Turn-off energy loss	$V_{CE} = 3600V$		2600		mJ
t <sub>d(on)</sub>	Turn-on delay time	$R_{G(ON)} = 4.7\Omega$ $R_{G(OFF)} = 15\Omega$ $C_{ge} = 220nF$ $L_{S} \sim 280nH$		900		ns
t <sub>r</sub>	Rise time			400		ns
E <sub>ON</sub>	Turn-on energy loss			3200		mJ
$Q_{rr}$	Diode reverse recovery charge	$I_F = 500A$ $V_{CE} = 3600V$ $dI_F/dt = 1400A/\mu s$		800		μC
I <sub>rr</sub>	Diode reverse recovery current			600		Α
E <sub>rec</sub>	Diode reverse recovery energy			1700		mJ

## $T_{case}$ = 125°C unless stated otherwise

Symbol	Parameter	Test Conditions	Min	Тур.	Max	Units
t <sub>d(off)</sub>	Turn-off delay time	I <sub>C</sub> = 500A		3.6		μs
t <sub>f</sub>	Fall time	$V_{GE} = \pm 15V$		450		ns
E <sub>OFF</sub>	Turn-off energy loss	$V_{CE} = 3600V$		2700		mJ
$t_{d(on)}$	Turn-on delay time	$R_{G(ON)} = 4.7\Omega$ $R_{G(OFF)} = 15\Omega$ $C_{ge} = 220 nF$ $L_{S} \sim 280 nH$		800		ns
t <sub>r</sub>	Rise time			450		ns
E <sub>ON</sub>	Turn-on energy loss			4000		mJ
$Q_{rr}$	Diode reverse recovery charge	$I_F = 500A$ $V_{CE} = 3600V$ $dI_F/dt = 1400A/\mu s$		1400		μC
I <sub>rr</sub>	Diode reverse recovery current			870		Α
E <sub>rec</sub>	Diode reverse recovery energy			3000		mJ

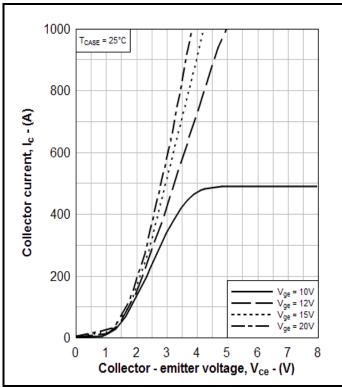


Fig. 3 Typical output characteristics

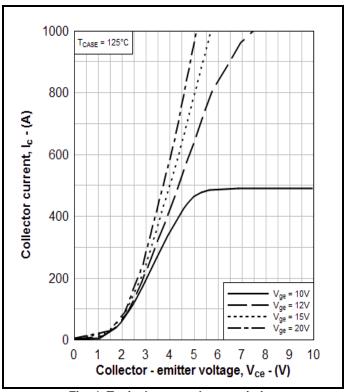


Fig. 4 Typical output characteristics

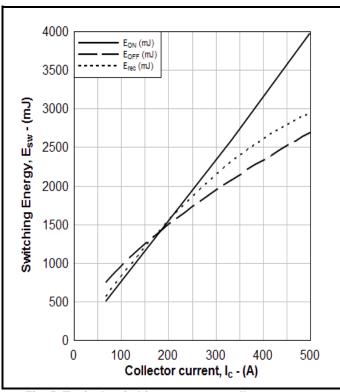


Fig. 5 Typical switching energy vs collector current

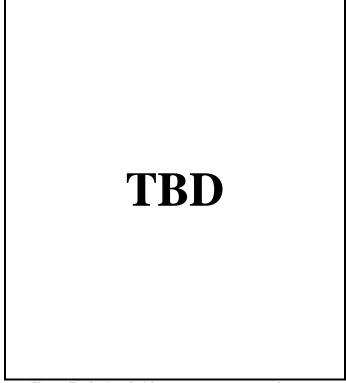


Fig. 6 Typical switching energy vs gate resistance

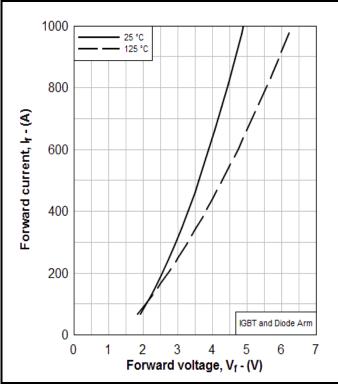


Fig. 7 Diode typical forward characteristics

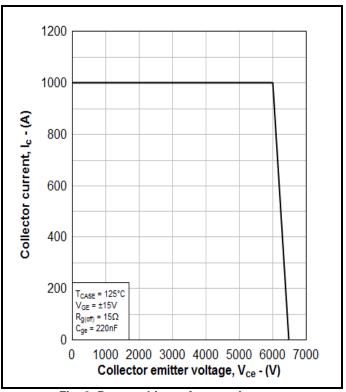


Fig. 8 Reverse bias safe operating area

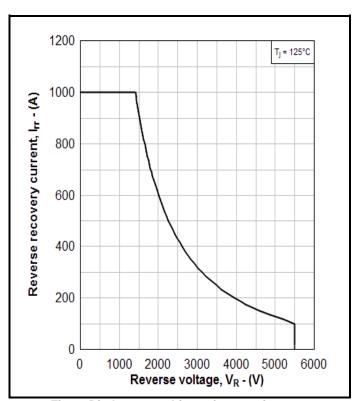


Fig. 9 Diode reverse bias safe operating area

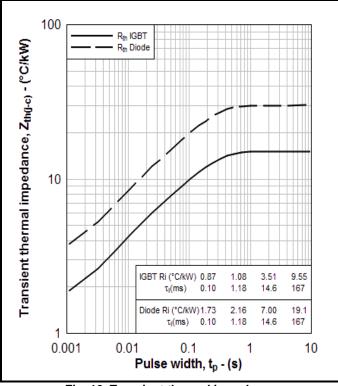


Fig. 10 Transient thermal impedance

## **PACKAGE DETAILS**

For further package information, please visit our website or contact Customer Services. All dimensions in mm, unless stated otherwise.

## DO NOT SCALE.

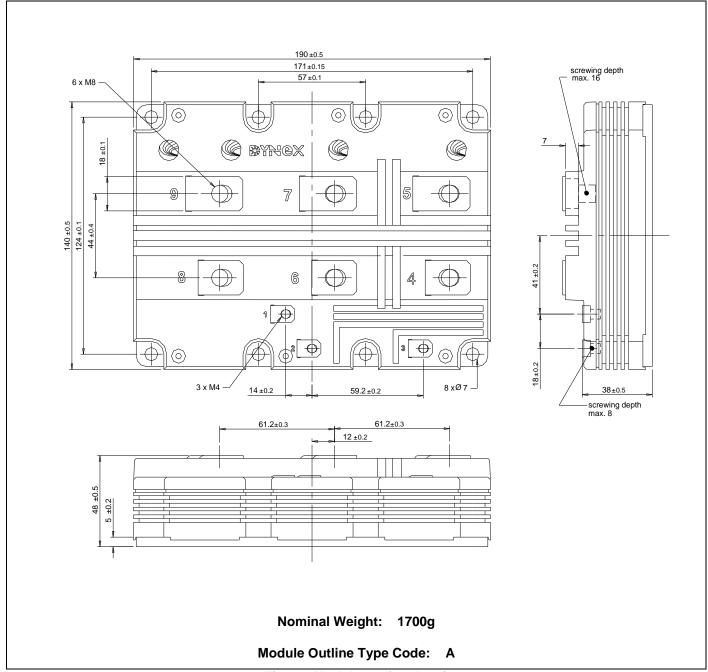


Fig. 11 Module outline drawing

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